

60V, 154A, 2.7mΩ N-channel Power SGT MOSFET

JMSL0603PG

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

- Load Switch
- PWM Application
- Power Management

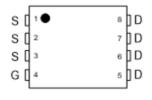
Product Summary

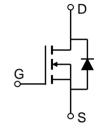
Parameters	Value	Unit
V_{DSS}	60	V
$V_{GS(th)_Typ}$	1.6	V
I _D (@V _{GS} =10V)	154	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	2.1	mΩ
$R_{DS(ON)_Typ}(@V_{GS}=4.5V$	2.7	mΩ











PDFN5X6-8L

Pin Assignment

Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSL0603PG	SL0603P	1	Tape&Reel	PDFN5x6-8L	5000	50000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		60	V
V_{GS}	Gate-to-Source Voltage		±20	V
I _D	Continuous Drain Current	$T_C = 25^{\circ}C$	154	^
ıD	Continuous Drain Current	$T_C = 100$ °C	109	A
I _{DM}	Pulsed Drain Current (1)		Refer to Fig.4	А
E _{AS}	Single Pulsed Avalanche Energ	gy ⁽²⁾	324	mJ
P _D	Power Dissipation	$T_C = 25^{\circ}C$	118	W
'D	Fower Dissipation	$T_C = 100$ °C	47	VV
T_{J}, T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol Parameter		Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	41	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.1	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

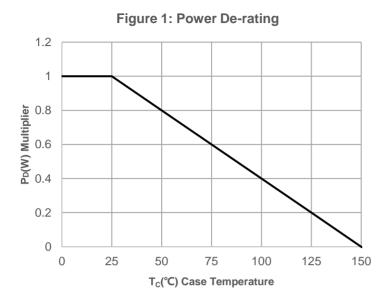
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	nracteristics					,
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.1	1.6	2.1	V
D	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	2.1	2.9	mΩ
$R_{DS(ON)}$	Static Drain-Source ON-Resistance	$V_{GS} = 4.5V, I_D = 15A$	-	2.7	3.8	mΩ
Dynami	c Characteristics					
R_{g}	Gate Resistance	f = 1MHz	-	2.1	-	Ω
C_{iss}	Input Capacitance	., ., ., ., ., ., ., ., ., ., ., ., ., .	2547	3566	4814	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ $f = 1MHz$	1249	1749	2361	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/2	74	103	140	pF
Qg	Total Gate Charge		44	62	84	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_D = 20A$	7	10	13	nC
Q_{gd}	Gate Drain("Miller") Charge	■ V _{DS} = 30V, I _D = 20A	10	14	19	nC
Switchi	ng Characteristics			ı	1	ı
$t_{d(on)}$	Turn-On DelayTime		-	11	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	28	-	ns
$t_{\text{d(off)}}$	Turn-Off DelayTime	$I_D = 20A$, $R_{GEN} = 3\Omega$	-	54	-	ns
t _f	Turn-Off Fall Time		-	30	-	ns
Body D	iode Characteristics					
Is	Maximum Continuous Body Diode Forward Current		-	-	154	Α
I_{SM}	Maximum Pulsed Body Diode Forward Cur	rent	-	-	618	Α
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	L = 20A di/dt = 100A/vs	40	57	76	ns
Qrr	Body Diode Reverse Recovery Charge	$I_F = 20A$, di/dt = 100A/us	-	69	-	nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- 2. E_{AS} condition: Starting T_J =25C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=3mH, I_{AS} =14.7A, V_{DD} =0V during time in avalanche.
- 3. $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.
- 4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.



Typical Performance Characteristics



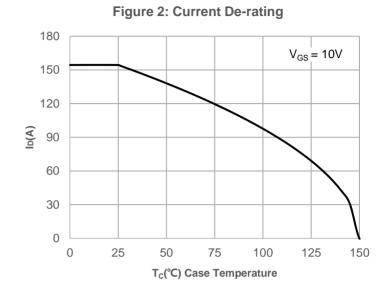
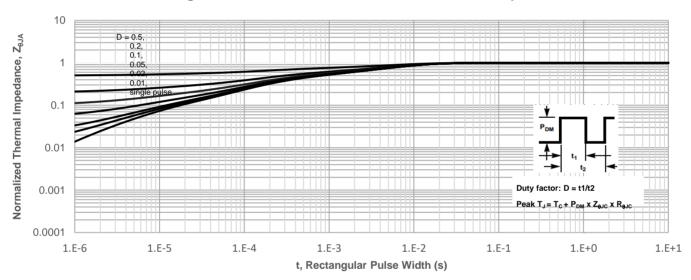
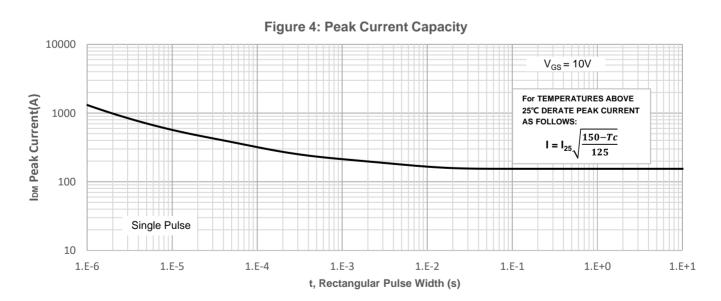


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

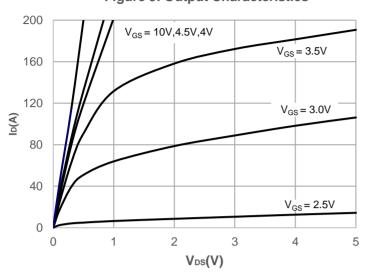


Figure 6: Typical Transfer Characteristics

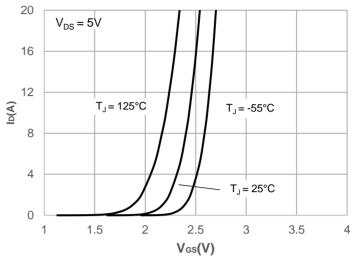


Figure 7: On-resistance vs. Drain Current

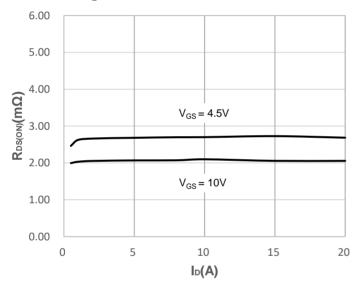


Figure 8: Body Diode Characteristics

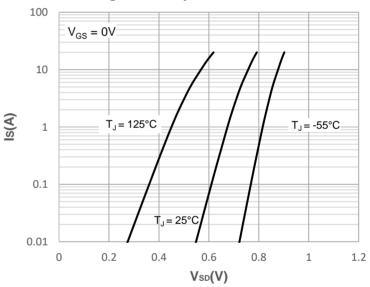


Figure 9: Gate Charge Characteristics

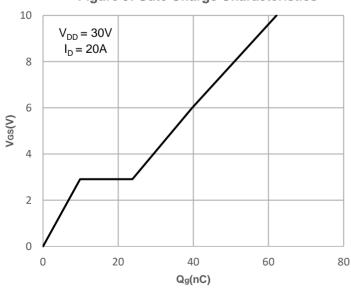
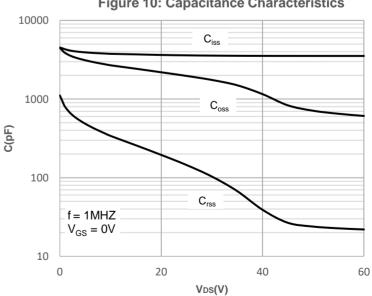


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

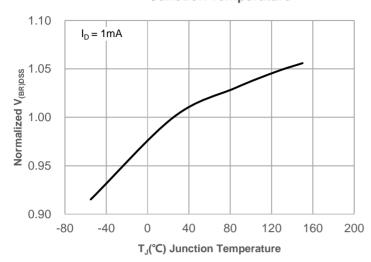


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

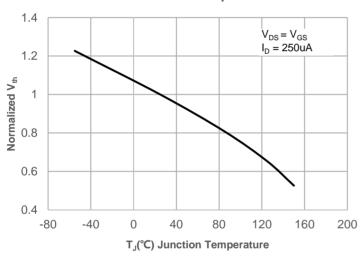


Figure 15: Maximum Safe Operating Area

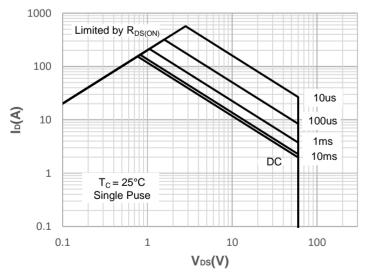
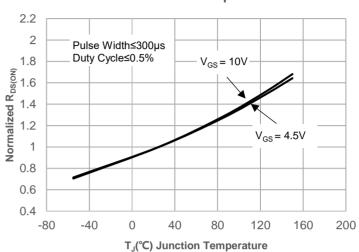
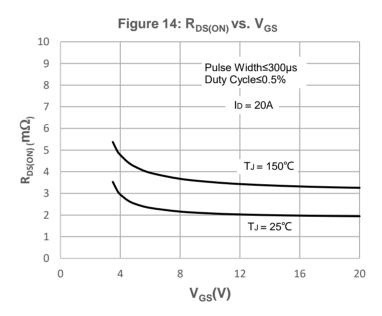


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

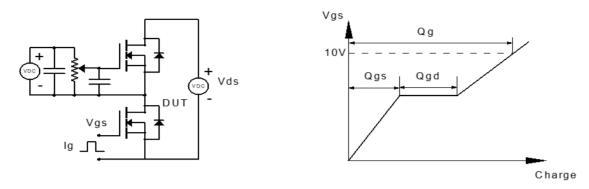


Figure 1: Gate Charge Test Circuit & Waveform

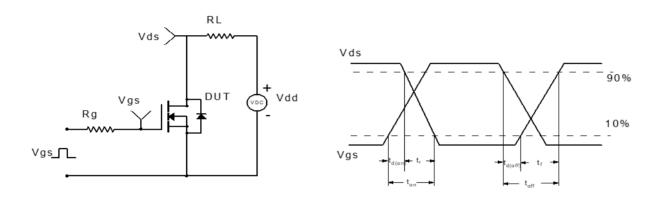


Figure 2: Resistive Switching Test Circuit & Waveform

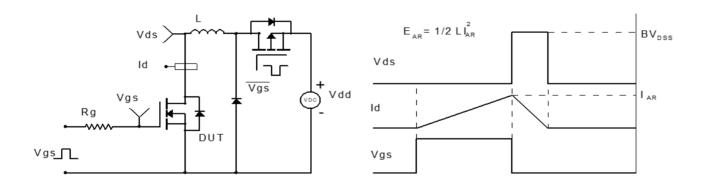


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

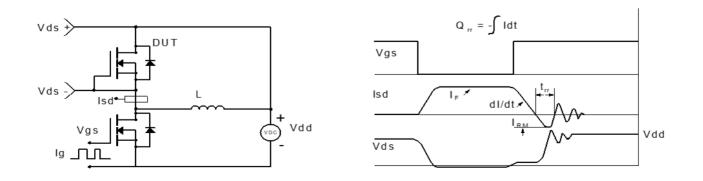
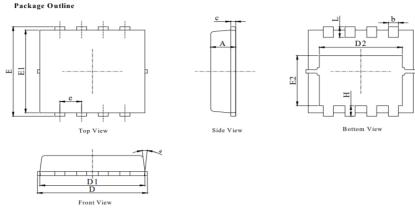


Figure 4: Diode Recovery Test Circuit & Waveform

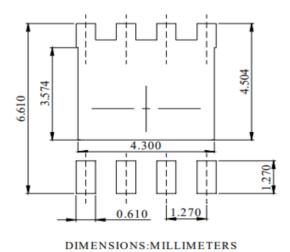


Package Mechanical Data(PDFN5X6-8L)



NOTES:					
	IMENSIONING AND TOLERANCING PER ASME				
	M,1994. DIMNESIONS IN MILLIMETER (ANNGLE IN DEGREE).				
	NSIONS DI AND EI DO NOT INCLUDE MOLD FLASH				
PROT	RUSIONS OR GATE BUR	RS.			
DIM.		MILLIMETER			
DIM.	MIN.	NOM.	MAX.		
A	0. 90	1.00	1. 10		
b	0.31	0.41	0. 51		
С	0. 20	0. 25	0.30		
D	5. 00	5. 20	5. 40		
D1	4. 95	5. 05	5. 15		
D 2	4.00	4. 10	4. 20		
Е	6. 05	6. 15	6. 25		
E1	5. 50	5. 60	5. 70		
E2	3. 42	3. 53	3. 63		
e		1. 27BSC			
Н	0.60	0. 70	0.80		
L	0.50	0.70	0.80		

Recommended Soldering Footprint



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